

<b>Notice of References Cited</b>	Application/Control No. 09/758,242	Applicant(s)/Patent Under Reexamination BHATTACHARYA ET AL.
	Examiner Kaveh Abrishamkar	Art Unit 2131

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,917,915 A	06-1999	Hirose, Masaki	380/228
	B	US-6,587,842 B1	07-2003	Walts, Keith	705/57
	C	US-6,754,827 B1	06-2004	Cane et al.	713/193
	D	US-6,374,363 B1	04-2002	Wu et al.	714/6
	E	US-5,659,614 A	08-1997	Bailey, III, John E.	713/165
	F	US-6,091,818 A	07-2000	Campinos et al.	713/155
	G	US-6,097,818 A	08-2000	Saito, Makoto	380/278
	H	US-6,363,357 B1	03-2002	Rosenberg et al.	705/26
	I	US-5,883,958 A	03-1999	Ishiguro et al.	705/57
	J	US-6,490,353 B1	12-2002	Tan, Daniel Tiong Hok	380/37
	K	US-6,398,245 B1	06-2002	Gruse et al.	280/228
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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